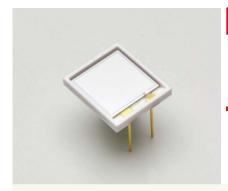


## Si PIN photodiode



S13993

# Large-area Si PIN photodiode for direct radiation detection

The S13993 is an unsealed type large-area Si PIN photodiode for direct radiation detection. Since the photosensitive area is coated with AI, there is no sensitivity in the ultraviolet to near infrared region.

#### Features

- ∃ High quantum efficiency
- → High energy resolution
- Low capacitance

#### Applications

- **Direct X-ray detection**
- Radiation detection (gamma-rays, beta-rays, charged particles, etc.)

#### Structure

Parameter	Specification	Unit
Photosensitive area	10 × 10	mm
Depletion layer thickness	0.3	mm
Package	Ceramic	-
Window material	None	-

#### - Absolute maximum ratings (Ta=25 °C)

Parameter	Symbol	Condition	Value	Unit
Reverse voltage	VR		100	V
Operating temperature	Topr	No dew condensation*1	-20 to +60	°C
Storage temperature	Tstg	No dew condensation*1	-20 to +80	°C

<sup>\*1:</sup> When there is a temperature difference between a product and the surrounding area in high humidity environments, dew condensation may occur on the product surface. Dew condensation on the product may cause deterioration in characteristics and relaiability.

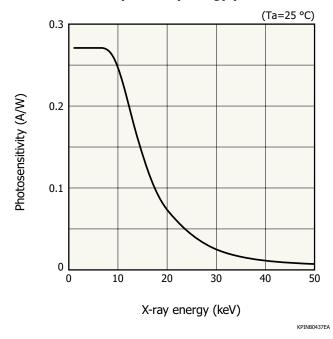
#### Electrical and optical characteristics (Ta=25 °C)

Parameter	Symbol	Condition	Min.	Тур.	Max.	Unit
X-ray energy	-		-	-	50	keV
Dark current	ID	VR=70 V	-	2	6	nA
Temperature coefficient of ID	ICID	VR=70 V	-	1.12	-	times/°C
Cutoff frequency*2		VR=70 V, RL=50 Ω λ=780 nm, -3 dB	-	40	-	MHz
Terminal capacitance	Ct	VR=70 V, f=10 kHz	-	40	60	pF

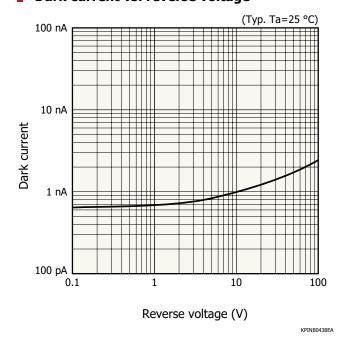
<sup>\*2:</sup> Without Al coating on photosensitive area

Note: Exceeding the absolute maximum ratings even momentarily may cause a drop in product quality. Always be sure to use the product within the absolute maximum ratings.

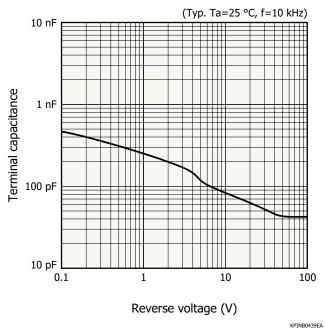
#### Photosensitivity vs. X-ray energy (theoretical value)



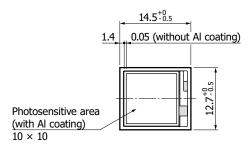
#### **⇒** Dark current vs. reverse voltage

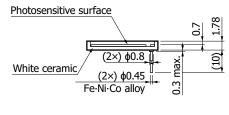


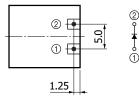
#### **Terminal capacitance vs. reverse voltage**



#### Dimensional outline (unit: mm)







Note: Al thickness on photosensitive surface approx. 1 µm

KPINA0125EB

#### Related information

www.hamamatsu.com/sp/ssd/doc\_en.html

- Precautions
- Disclaimer
- · Precautions / Metal, ceramic, plastic package products
- · Precautions / Unsealed products
- Catalogs
- · Selection guide / Si photodiodes
- · Technical note / X-ray detectors

Information described in this material is current as of December 2024.

Product specifications are subject to change without prior notice due to improvements or other reasons. This document has been carefully prepared and the information contained is believed to be accurate. In rare cases, however, there may be inaccuracies such as text errors. Before using these products, always contact us for the delivery specification sheet to check the latest specifications.

The product warranty is valid for one year after delivery and is limited to product repair or replacement for defects discovered and reported to us within that one year period. However, even if within the warranty period we accept absolutely no liability for any loss caused by natural disasters or improper product use. Copying or reprinting the contents described in this material in whole or in part is prohibited without our prior permission.

### MAMATSU

www.hamamatsu.com

HAMAMATSU PHOTONICS K.K., Solid State Division

1126-1 Ichino-cho, Chuo-ku, Hamamatsu City, 435-8558 Japan, Telephone: (81)53-434-3311, Fax: (81)53-434-5184